

Notice of References Cited		Application/Control No. 10/086,375	Applicant(s)/Patent Under Reexamination KWEAN ET AL.	
		Examiner Binh X Tran	Art Unit 1765	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,468,859	10-2002	Parekh et al.	438/255
	B	US-6,429,087	08-2002	Kwok et al.	438/381
	C	US-6,358,842	03-2002	Zhou et al.	438/633
	D	US-6,174,769	01-2001	Lou, Chine-Gie	438/253
	E	US-6,051,485	04-2000	Schindler et al.	438/577
	F	US-5,821,141	10-1998	Huang, Jenn Ming	438/253
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.